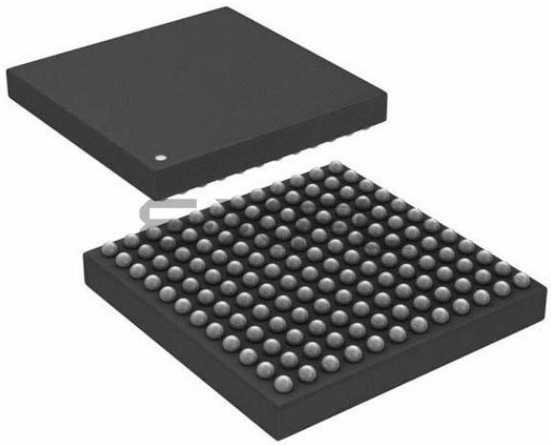
Infineon Technologies - XMC4500E144X1024ACXQSA1 Datasheet



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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	120MHz
Connectivity	CANbus, EBI/EMI, Ethernet, I²C, LINbus, SPI, UART, USB
Peripherals	DMA, I²S, LED, POR, PWM, WDT
Number of I/O	91
Program Memory Size	1MB (1M x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	160K x 8
Voltage - Supply (Vcc/Vdd)	3.13V ~ 3.63V
Data Converters	A/D 32x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LFBGA
Supplier Device Package	PG-LFBGA-144-10
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/xmc4500e144x1024acxqsa1

XMC4500 Data Sheet

Revision History: V1.4 2016-01

Previous Versions:
V1.3, 2014-03
V1.2, 2013-07
V1.1, 2013-07
V1.0, 2013-01
V0.9, 2012-12
V0.8, 2012-11

Page	Subjects
43	Added information that $\overline{\text{PORST}}$ Pull-up is identical to the pull-up on standard I/O pins.
42	Added footnote explaining minimum V_{BAT} requirements to start the hibernate domain and/or oscillation of a crystal on RTC_XTAL.
59	Corrected parameter name of of USB pull device (upstream port receiving) definition according to USB standard (referenced to DM instead of DP)
61	Relaxed RTC_XTAL V_{PPX} parameter value and changed it to a system requirement.
115ff	Added PG-LQFP-100-25 and PG-LQFP-144-24 package information.
115	Added tables describing the differences between PG-LQFP-100-11 to PG-LQFP-100-25 as well as PG-LQFP-144-18 to PG-LQFP-144-24 packages.

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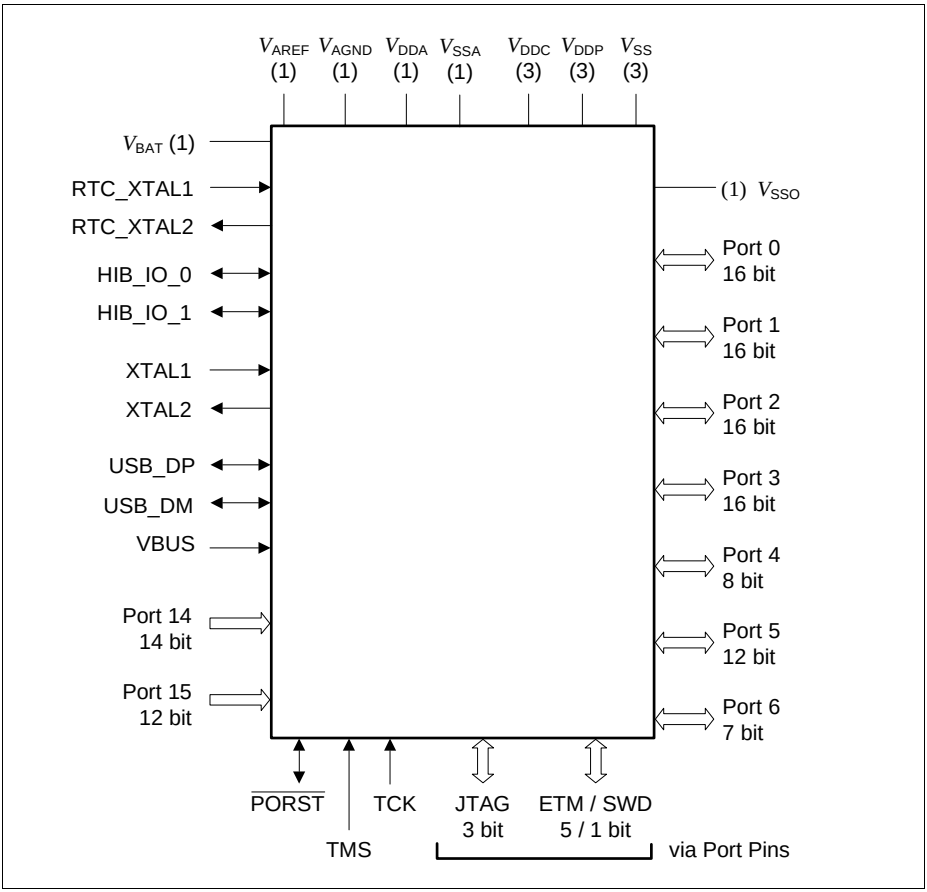

Figure 3 XMC4500 Logic Symbol PG-LFBGA-144

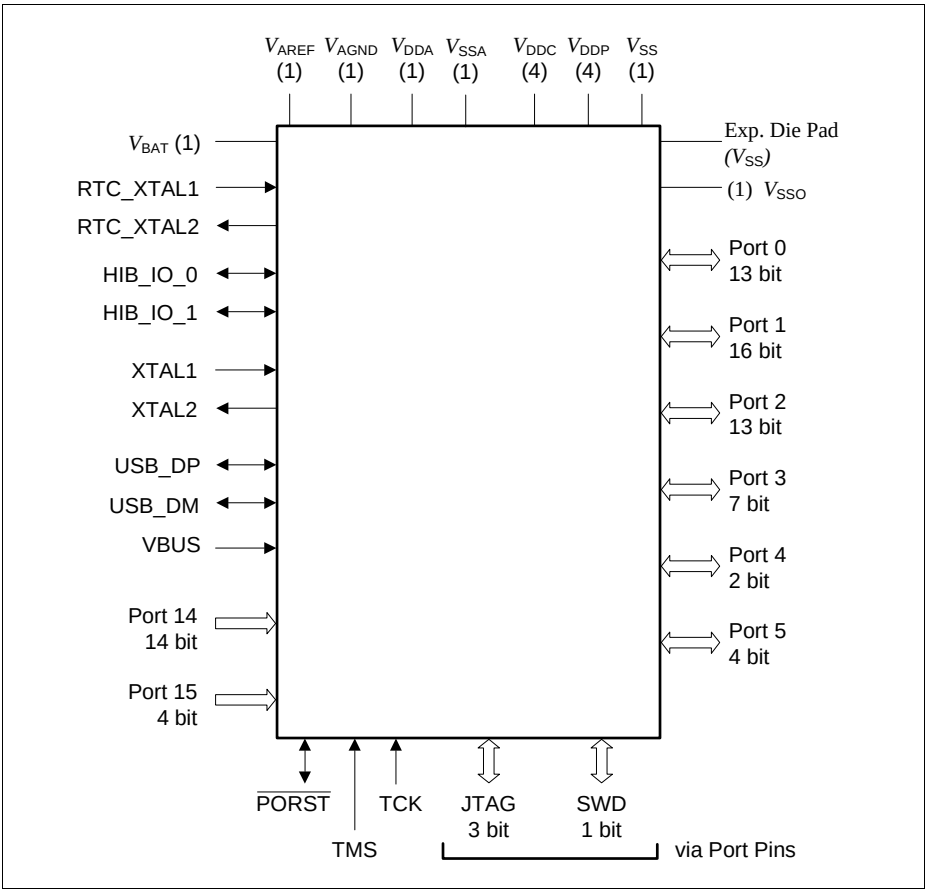

Figure 4 XMC4500 Logic Symbol PG-LQFP-100

2.2.1 Package Pin Summary

The following general scheme is used to describe each pin:

Table 8 Package Pin Mapping Description

Function	Package A	Package B	...	Pad Type	Notes
Name	N	Ax	...	A2	

The table is sorted by the “Function” column, starting with the regular Port pins (Px.y), followed by the dedicated pins (i.e. PORST) and supply pins.

The following columns, titled with the supported package variants, lists the package pin number to which the respective function is mapped in that package.

The “Pad Type” indicates the employed pad type (A1, A1+, A2, special=special pad, In=input pad, AN/DIG_IN=analog and digital input, Power=power supply). Details about the pad properties are defined in the Electrical Parameters.

In the “Notes”, special information to the respective pin/function is given, i.e. deviations from the default configuration after reset. Per default the regular Port pins are configured as direct input with no internal pull device active.

Table 9 Package Pin Mapping

Function	LQFP-144	LFBGA-144	LQFP-100	Pad Type	Notes
P0.0	2	C4	2	A1+	
P0.1	1	C3	1	A1+	
P0.2	144	A3	100	A2	
P0.3	143	A4	99	A2	
P0.4	142	B5	98	A2	
P0.5	141	A5	97	A2	
P0.6	140	A6	96	A2	
P0.7	128	B7	89	A2	After a system reset, via HWSEL this pin selects the DB.TDI function.
P0.8	127	A8	88	A2	After a system reset, via HWSEL this pin selects the DB.TRST function, with a weak pull-down active.
P0.9	4	D4	4	A2	
P0.10	3	B4	3	A1+	

Table 9 Package Pin Mapping (cont'd)

Function	LQFP-144	LFBGA-144	LQFP-100	Pad Type	Notes
P2.10	66	L8	44	A2	
P2.11	65	M8	-	A2	
P2.12	64	L7	-	A2	
P2.13	63	M7	-	A2	
P2.14	60	K7	41	A2	
P2.15	59	J6	40	A2	
P3.0	7	C1	7	A2	
P3.1	6	B2	6	A2	
P3.2	5	B3	5	A2	
P3.3	132	F7	93	A1+	
P3.4	131	E7	92	A1+	
P3.5	130	B6	91	A2	
P3.6	129	A7	90	A2	
P3.7	14	E4	-	A1+	
P3.8	13	E3	-	A1+	
P3.9	12	F5	-	A1+	
P3.10	11	F6	-	A1+	
P3.11	10	D3	-	A1+	
P3.12	9	D2	-	A2	
P3.13	8	C2	-	A2	
P3.14	134	D6	-	A1+	
P3.15	133	D7	-	A1+	
P4.0	124	B8	85	A2	
P4.1	123	A9	84	A2	
P4.2	122	E8	-	A1+	
P4.3	121	F8	-	A1+	
P4.4	120	C7	-	A1+	
P4.5	119	D8	-	A1+	
P4.6	118	C8	-	A1+	
P4.7	117	C9	-	A1+	
P5.0	84	H9	58	A1+	
P5.1	83	H8	57	A1+	
P5.2	82	H7	56	A1+	

Table 9 Package Pin Mapping (cont'd)

Function	LQFP-144	LFBGA-144	LQFP-100	Pad Type	Notes
VSSO	89	J12	63	Power	
VSS	Exp. Pad	-	Exp. Pad	Power	**Exposed Die Pad** The exposed die pad is connected internally to VSS. For proper operation, it is mandatory to connect the exposed pad directly to the common ground on the board. For thermal aspects, please refer to the Data Sheet. Board layout examples are given in an application note.

Table 11 Port I/O Functions (cont'd)

Function	Outputs						Inputs									
	ALT1	ALT2	ALT3	ALT4	HWO0	HWO1	HWI0	HWI1	Input	Input	Input	Input	Input	Input	Input	Input
P1.5	CAN. N1_TXD	U0C0. DOUT0	CCU80. OUT23	CCU81. OUT10	U0C0. DOUT0		U0C0. HWIN0		U0C0. DX0A	CAN. N0_RXDA	ERU0. 2A0	ERU1. 0A0	CCU41. IN1C	DSD. DIN2B		
P1.6		U0C0. SCLKOUT			SDMMC. DATA1_OUT	EBU. AD10	SDMMC. DATA1_IN	EBU. D10	DSD. DIN2A							
P1.7		U0C0. DOUT0	DSD. MCLK2		SDMMC. DATA2_OUT	EBU. AD11	SDMMC. DATA2_IN	EBU. D11		DSD. MCLK2A						
P1.8		U0C0. SELO1	DSD. MCLK1		SDMMC. DATA4_OUT	EBU. AD12	SDMMC. DATA4_IN	EBU. D12	CAN. N2_RXDA	DSD. MCLK1A						
P1.9		CAN. N2_TXD			SDMMC. DATA5_OUT	EBU. AD13	SDMMC. DATA5_IN	EBU. D13		DSD. MCLK0A						
P1.10	ETH0. MDC	U0C0. SCLKOUT	CCU81. OUT21				SDMMC. SDCD						CCU41. IN2C			
P1.11		U0C0. SELO0	CCU81. OUT11		ETH0. MDO		ETH0. MDIC						CCU41. IN3C			
P1.12	ETH0. TX_EN	CAN. N1_TXD	CCU81. OUT01		SDMMC. DATA6_OUT	EBU. AD16	SDMMC. DATA6_IN	EBU. D16								
P1.13	ETH0. TXD0	U0C1. SELO3	CCU81. OUT20		SDMMC. DATA7_OUT	EBU. AD17	SDMMC. DATA7_IN	EBU. D17	CAN. N1_RXDC							
P1.14	ETH0. TXD1	U0C1. SELO2	CCU81. OUT10			EBU. AD18		EBU. D18								
P1.15	SCU. EXTCLK	DSD. MCLK2	CCU81. OUT00			EBU. AD19		EBU. D19		DSD. MCLK2B		ERU1. 1A0				
P2.0		CCU81. OUT21	DSD. CGPWMN	LEDTS0. COL1	ETH0. MDO	EBU. AD20	ETH0. MDIB	EBU. D20			ERU0. 0B3		CCU40. IN1C			
P2.1		CCU81. OUT11	DSD. CGPWMP	LEDTS0. COL0	DB.TDO/ TRACESWO	EBU. AD21		EBU. D21	ETH0. CLK_RMIIA			ERU1. 0B0	CCU40. IN0C			ETH0. CLKRXA
P2.2	VADC. EMUX00	CCU81. OUT01	CCU41. OUT3	LEDTS0. LINE0	LEDTS0. EXTENDED0	EBU. AD22	LEDTS0. TSIN0A	EBU. D22	ETH0. RXD0A	U0C1. DX0A	ERU0. 1B2		CCU41. IN3A			
P2.3	VADC. EMUX01	U0C1. SELO0	CCU41. OUT2	LEDTS0. LINE1	LEDTS0. EXTENDED1	EBU. AD23	LEDTS0. TSIN1A	EBU. D23	ETH0. RXD1A	U0C1. DX2A	ERU0. 1A2	POSIF1. IN2A	CCU41. IN2A			
P2.4	VADC. EMUX02	U0C1. SCLKOUT	CCU41. OUT1	LEDTS0. LINE2	LEDTS0. EXTENDED2	EBU. AD24	LEDTS0. TSIN2A	EBU. D24	ETH0. RXERA	U0C1. DX1A	ERU0. 0B2	POSIF1. IN1A	CCU41. IN1A			
P2.5	ETH0. TX_EN	U0C1. DOUT0	CCU41. OUT0	LEDTS0. LINE3	LEDTS0. EXTENDED3	EBU. AD25	LEDTS0. TSIN3A	EBU. D25	ETH0. RXDVA	U0C1. DX0B	ERU0. 0A2	POSIF1. IN0A	CCU41. IN0A			ETH0. CRS_DVA
P2.6	U2C0. SELO4		CCU80. OUT13	LEDTS0. COL3	U2C0. DOUT3		U2C0. HWIN3		DSD. DIN1B	CAN. N1_RXDA	ERU0. 1B3		CCU40. IN3C			
P2.7	ETH0. MDC	CAN. N1_TXD	CCU80. OUT03	LEDTS0. COL2					DSD. DIN0B			ERU1. 1B0	CCU40. IN2C			
P2.8	ETH0. TXD0		CCU80. OUT32	LEDTS0. LINE4	LEDTS0. EXTENDED4	EBU. AD26	LEDTS0. TSIN4A	EBU. D26	DAC. TRIGGER5				CCU40. IN0B	CCU40. IN1B	CCU40. IN2B	CCU40. IN3B
P2.9	ETH0. TXD1		CCU80. OUT22	LEDTS0. LINE5	LEDTS0. EXTENDED5	EBU. AD27	LEDTS0. TSIN5A	EBU. D27	DAC. TRIGGER4				CCU41. IN0B	CCU41. IN1B	CCU41. IN2B	CCU41. IN3B
P2.10	VADC. EMUX10				DB. ETM_TRACEDATA3	EBU. AD28		EBU. D28								
P2.11	ETH0. TXER		CCU80. OUT22		DB. ETM_TRACEDATA2	EBU. AD29		EBU. D29								

Table 11 Port I/O Functions (cont'd)

Function	Outputs						Inputs									
	ALT1	ALT2	ALT3	ALT4	HWO0	HWO1	HWI0	HWI1	Input	Input	Input	Input	Input	Input	Input	Input
P6.6			DSD. MCLK3		DB. ETM_TRACEDATA0	EBU. BC3			DSD. MCLK3A	ETH0. CLK_TXB						
P14.0									VADC. G0CH0							
P14.1									VADC. G0CH1							
P14.2									VADC. G0CH2	VADC. G1CH2						
P14.3									VADC. G0CH3	VADC. G1CH3			CAN. N0_RXDB			
P14.4									VADC. G0CH4		VADC. G2CH0					
P14.5									VADC. G0CH5		VADC. G2CH1		POSIF0. IN2B			
P14.6									VADC. G0CH6				POSIF0. IN1B		G0ORC6	
P14.7									VADC. G0CH7				POSIF0. IN0B		G0ORC7	
P14.8					DAC. OUT_0					VADC. G1CH0		VADC. G3CH2	ETH0. RXD0C			
P14.9					DAC. OUT_1					VADC. G1CH1		VADC. G3CH3	ETH0. RXD1C			
P14.12										VADC. G1CH4						
P14.13										VADC. G1CH5						
P14.14										VADC. G1CH6					G1ORC6	
P14.15										VADC. G1CH7					G1ORC7	
P15.2											VADC. G2CH2					
P15.3											VADC. G2CH3					
P15.4											VADC. G2CH4					
P15.5											VADC. G2CH5					
P15.6											VADC. G2CH6					
P15.7											VADC. G2CH7					
P15.8												VADC. G3CH0	ETH0. CLK_RMIIC			ETH0. CLKRXC
P15.9												VADC. G3CH1	ETH0. CRS_DVC			ETH0. RXDVC

3 Electrical Parameters

3.1 General Parameters

3.1.1 Parameter Interpretation

The parameters listed in this section partly represent the characteristics of the XMC4500 and partly its requirements on the system. To aid interpreting the parameters easily when evaluating them for a design, they are marked with a two-letter abbreviation in column “Symbol”:

- **CC**
  Such parameters indicate **C**ontroller **C**haracteristics, which are a distinctive feature of the XMC4500 and must be regarded for system design.
- **SR**
  Such parameters indicate **S**ystem **R**equirements, which must be provided by the application system in which the XMC4500 is designed in.

3.1.4 Pad Driver and Pad Classes Summary

This section gives an overview on the different pad driver classes and their basic characteristics.

Table 17 Pad Driver and Pad Classes Overview

Class	Power Supply	Type	Sub-Class	Speed Grade	Load	Termination
A	3.3 V	LVTTL I/O	**A1** (e.g. GPIO)	6 MHz	100 pF	No
			A1+ (e.g. serial I/Os)	25 MHz	50 pF	Series termination recommended
			A2 (e.g. ext. Bus)	80 MHz	15 pF	Series termination recommended

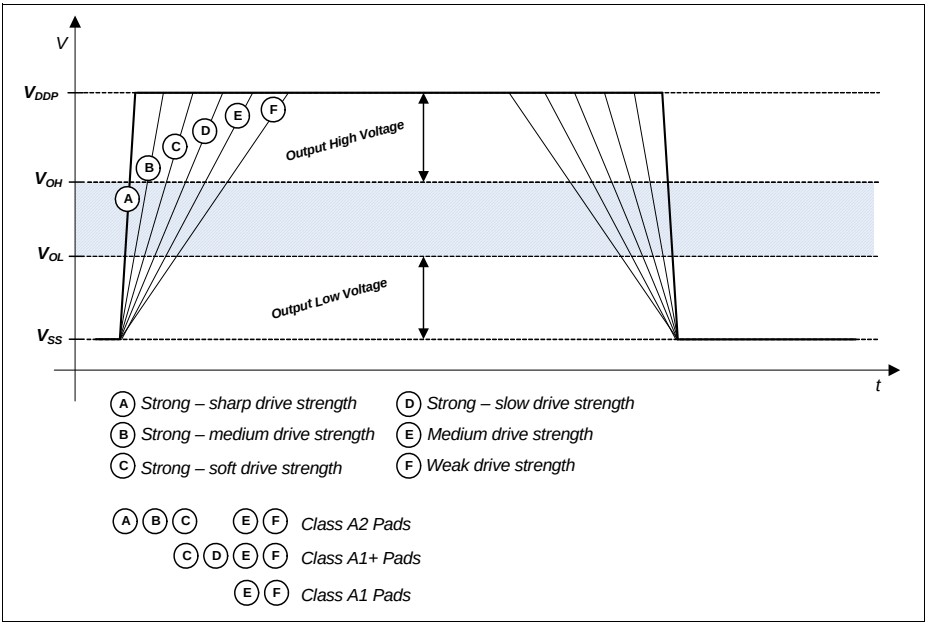

Figure 12 Output Slopes with different Pad Driver Modes

Figure 12 is a qualitative display of the resulting output slope performance with different output driver modes. The detailed input and output characteristics are listed in **Section 3.2.1**.

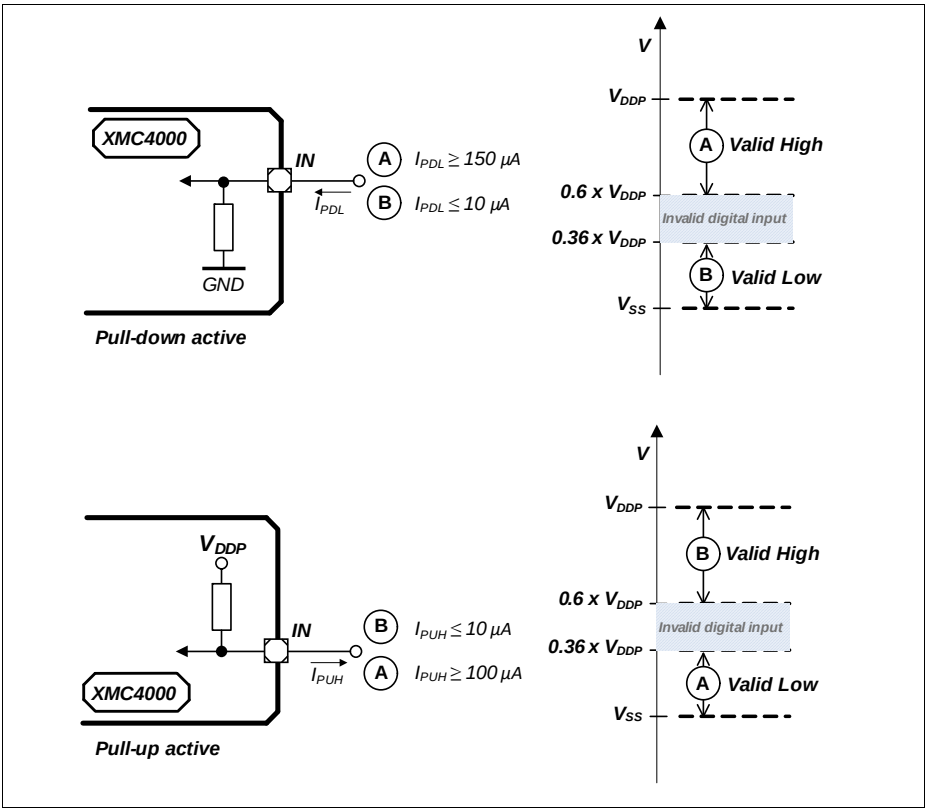

Figure 13 Pull Device Input Characteristics

Figure 13 visualizes the input characteristics with an active internal pull device:

- in the cases “A” the internal pull device is overridden by a strong external driver;
- in the cases “B” the internal pull device defines the input logical state against a weak external load.

Table 22 Standard Pads Class_A2

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.		Max.		
Fall time	t_{FA2} CC	–		150	ns	C_L = 20 pF; POD = weak
		–		50	ns	C_L = 50 pF; POD = medium
		–		3.7	ns	C_L = 50 pF; POD = strong; edge = sharp
		–		7	ns	C_L = 50 pF; POD = strong; edge = medium
		–		16	ns	C_L = 50 pF; POD = strong; edge = soft
Rise time	t_{RA2} CC	–		150	ns	C_L = 20 pF; POD = weak
		–		50	ns	C_L = 50 pF; POD = medium
		–		3.7	ns	C_L = 50 pF; POD = strong; edge = sharp
		–		7.0	ns	C_L = 50 pF; POD = strong; edge = medium
		–		16	ns	C_L = 50 pF; POD = strong; edge = soft

Table 29 USB OTG Data Line (USB_DP, USB_DM) Parameters (Operating Conditions apply)

Parameter	Symbol		Values			Unit	Note / Test Condition
			Min.	Typ.	Max.		
Input low voltage	V_{IL}	SR	–	–	0.8	V	
Input high voltage (driven)	V_{IH}	SR	2.0	–	–	V	
Input high voltage (floating) [1]	V_{IHZ}	SR	2.7	–	3.6	V	
Differential input sensitivity	V_{DIS}	CC	0.2	–	–	V	
Differential common mode range	V_{CM}	CC	0.8	–	2.5	V	
Output low voltage	V_{OL}	CC	0.0	–	0.3	V	1.5 kOhm pull-up to 3.6 V
Output high voltage	V_{OH}	CC	2.8	–	3.6	V	15 kOhm pull-down to 0 V
DP pull-up resistor (idle bus)	R_{PUI}	CC	900	–	1 575	Ohm	
DP pull-up resistor (upstream port receiving)	R_{PUA}	CC	1 425	–	3 090	Ohm	
DP, DM pull-down resistor	R_{PD}	CC	14.25	–	24.8	kOhm	
Input impedance DP, DM	Z_{INP}	CC	300	–	–	kOhm	$0\ V \le V_{IN} \le V_{DDP}$
Driver output resistance DP, DM	Z_{DRV}	CC	28	–	44	Ohm	

1) Measured at A-connector with 1.5 kOhm ± 5% to 3.3 V ± 0.3 V connected to USB_DP or USB_DM and at B-connector with 15 kOhm ± 5% to ground connected to USB_DP and USB_DM.

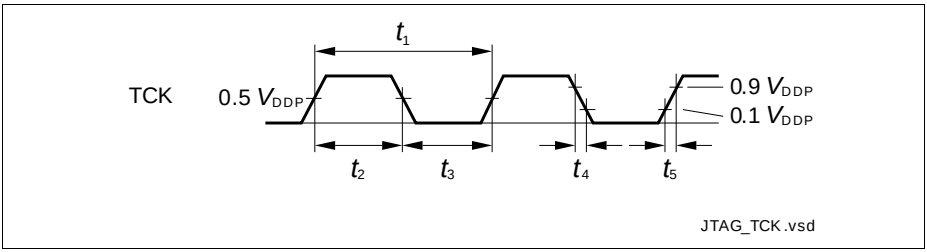

Figure 27 Test Clock Timing (TCK)

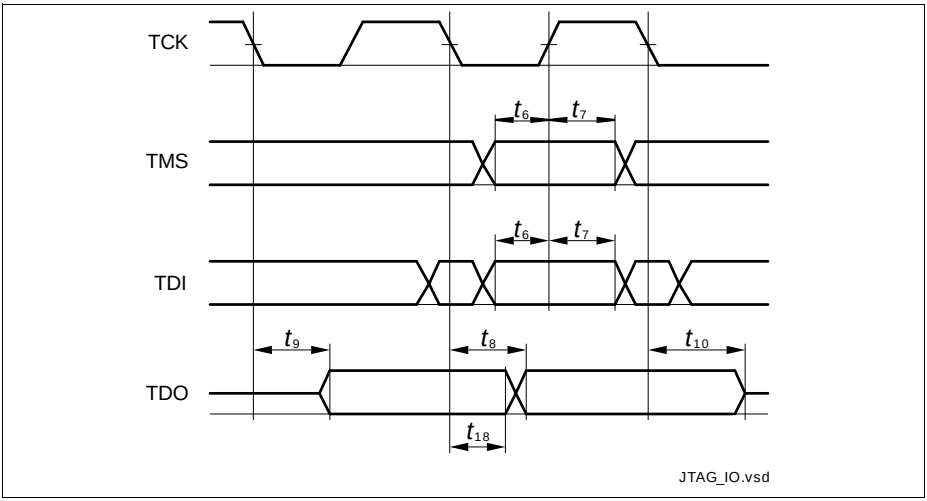

Figure 28 JTAG Timing

3.3.9 Peripheral Timing

3.3.9.1 Delta-Sigma Demodulator Digital Interface Timing

The following parameters are applicable for the digital interface of the Delta-Sigma Demodulator (DSD).
The data timing is relative to the active clock edge. Depending on the operation mode of the connected modulator that can be the rising and falling clock edge.

Note: These parameters are not subject to production test, but verified by design and/or characterization.

Table 42 DSD Interface Timing Parameters

Parameter	Symbol		Values			Unit	Note / Test Condition
			Min.	Typ.	Max.		
MCLK period in master mode	t_1	CC	33.3	–	–	ns	$t_1 \geq 4 \times t_{PERIPH}$ [1]
MCLK high time in master mode	t_2	CC	9	–	–	ns	$t_2 > t_{PERIPH}$ [1]
MCLK low time in master mode	t_3	CC	9	–	–	ns	$t_3 > t_{PERIPH}$ [1]
MCLK period in slave mode	t_1	SR	33.3	–	–	ns	$t_1 \geq 4 \times t_{PERIPH}$ [1]
MCLK high time in slave mode	t_2	SR	t_{PERIPH}	–	–	ns	[1]
MCLK low time in slave mode	t_3	SR	t_{PERIPH}	–	–	ns	[1]
DIN input setup time to the active clock edge	t_4	SR	t_{PERIPH} + 4	–	–	ns	[1]
DIN input hold time from the active clock edge	t_5	SR	t_{PERIPH} + 3	–	–	ns	[1]

1) $t_{PERIPH} = 1 / f_{PERIPH}$

Multiplexed Write Timing

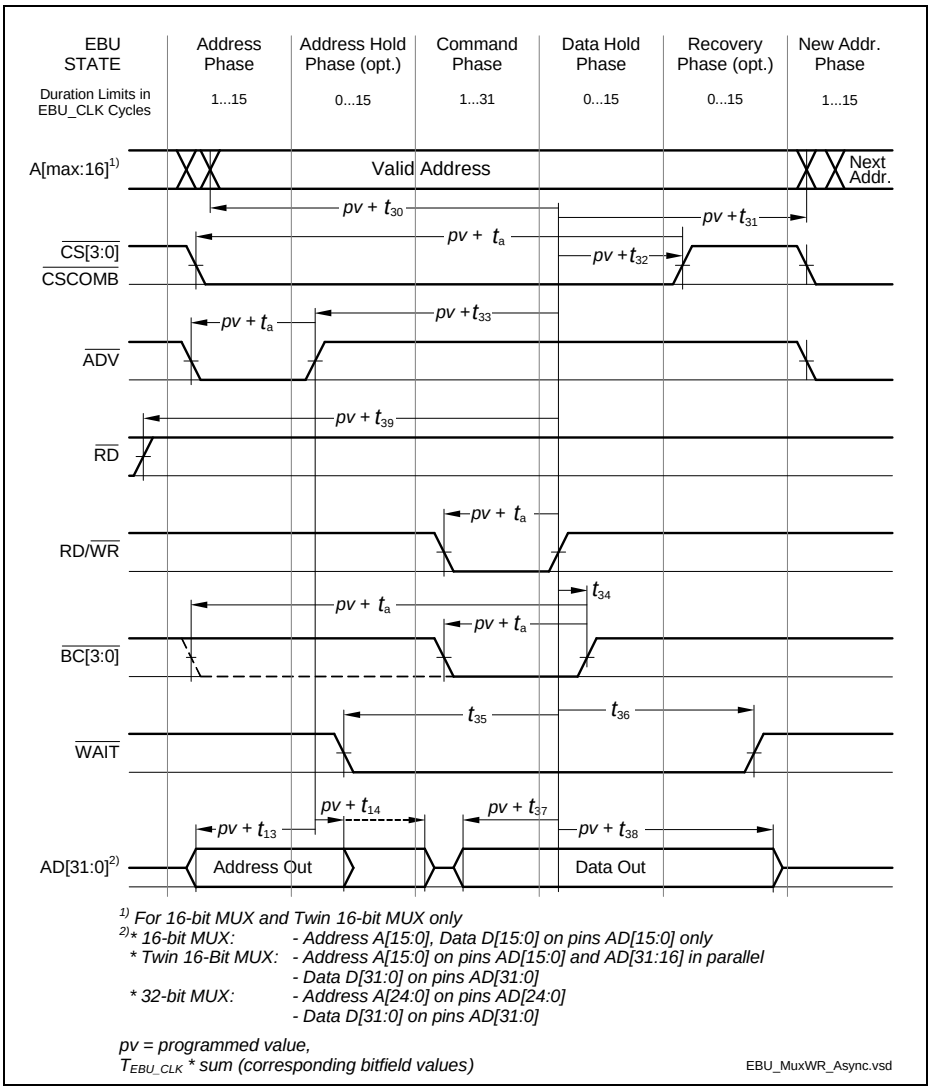

Figure 43 Multiplexed Write Access

power dissipation must be limited so that the average junction temperature does not exceed 150 °C.

The difference between junction temperature and ambient temperature is determined by
$\Delta T = (P_{INT} + P_{IOSTAT} + P_{IODYN}) \times R_{\Theta JA}$

The internal power consumption is defined as
$P_{INT} = V_{DDP} \times I_{DDP}$ (switching current and leakage current).

The static external power consumption caused by the output drivers is defined as
$P_{IOSTAT} = \Sigma((V_{DDP}-V_{OH}) \times I_{OH}) + \Sigma(V_{OL} \times I_{OL})$

The dynamic external power consumption caused by the output drivers (P_{IODYN}) depends on the capacitive load connected to the respective pins and their switching frequencies.

If the total power dissipation for a given system configuration exceeds the defined limit, countermeasures must be taken to ensure proper system operation:

- Reduce V_{DDP}, if possible in the system
- Reduce the system frequency
- Reduce the number of output pins
- Reduce the load on active output drivers

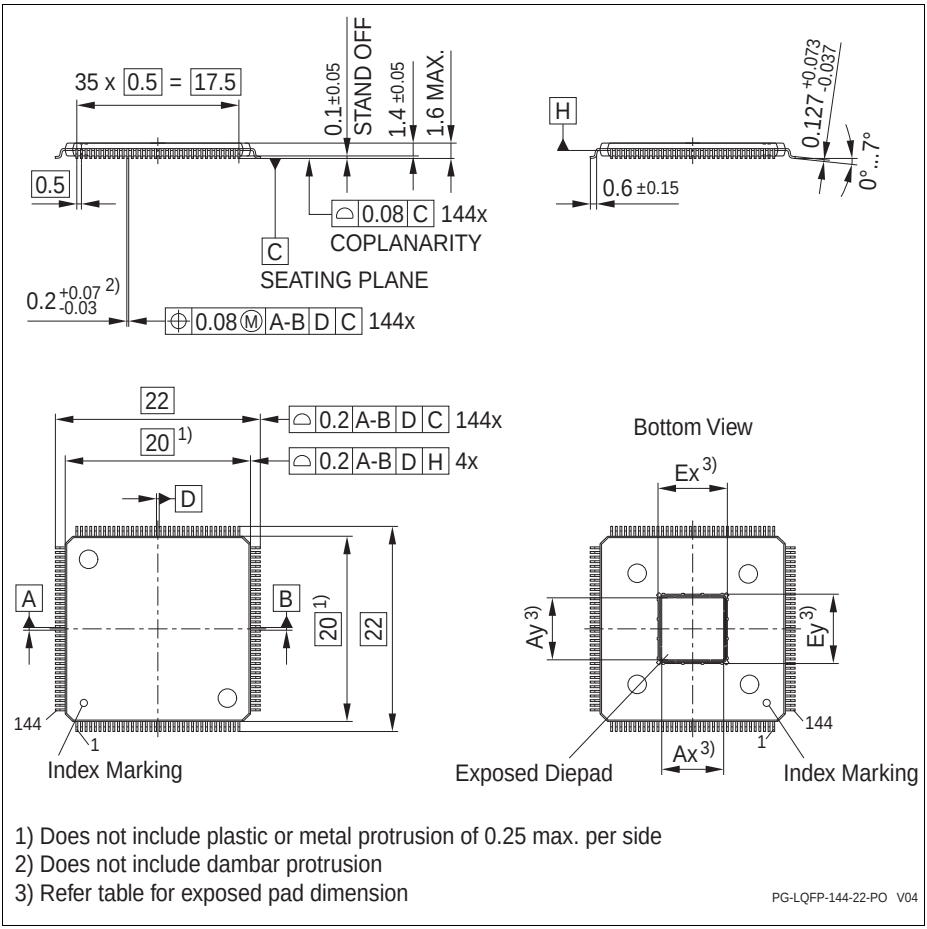

Figure 56 PG-LQFP-144-24 (Plastic Green Low Profile Quad Flat Package)

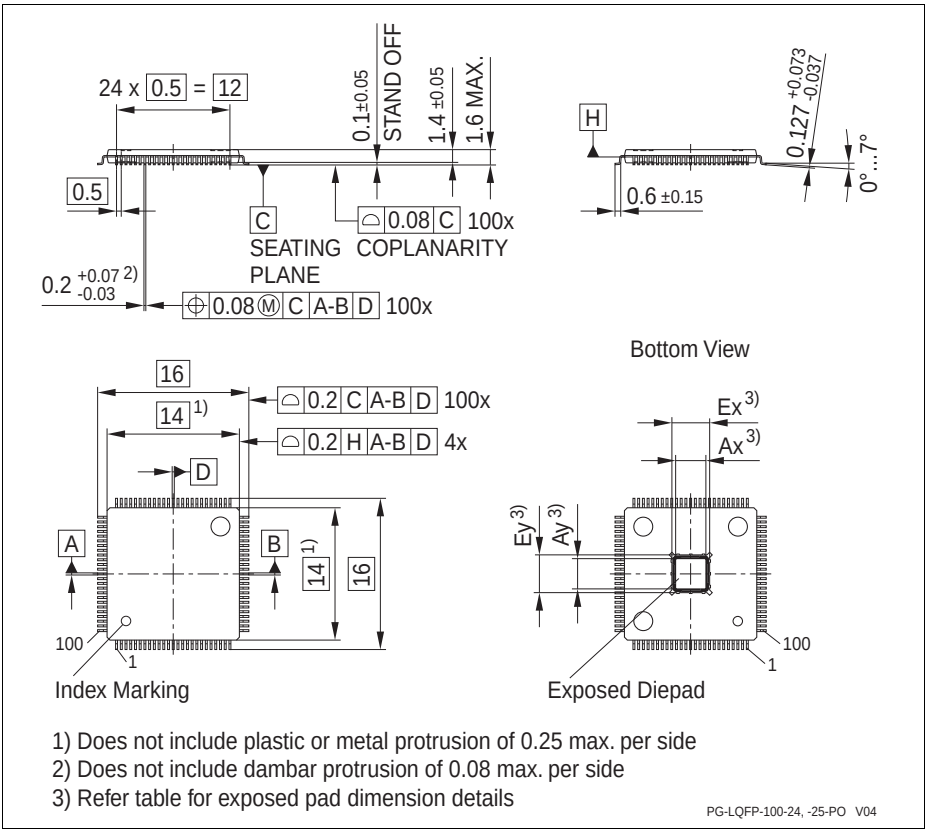

Figure 58 PG-LQFP-100-25 (Plastic Green Low Profile Quad Flat Package)